

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/712,777 SCHMIDT ET AL.	
		Examiner	Art Unit	Page 1 of 1 Ajay Vasudeva 3617

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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